# **Thermal Degradation of Alkali Antimonide Cathodes**

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PHYSICAL REVIEW ACCELERATORS AND BEAMS **20,** 113401 (2017)

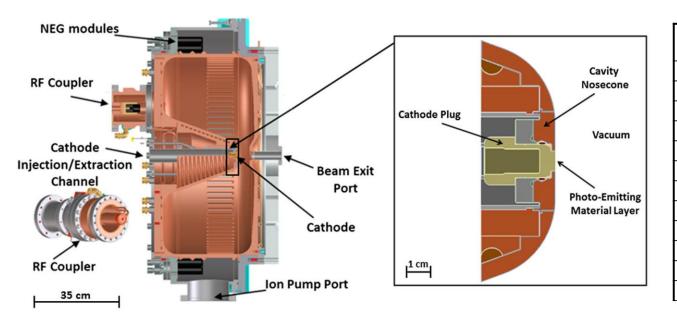






# **APEX Photoinjector**

F. Sannibale *et al.*, Advanced photoinjector experiment photogun commissioning results, Phys. Rev. ST Accel. Beams **15**, 103501 (2012).



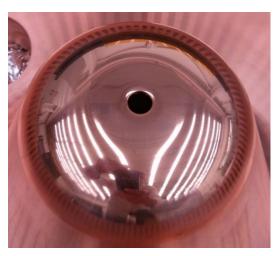
Frequency (7 <sup>th</sup> sub-harmonic of 1.3 GHz)	186 MHz
Operation mode	CW
Gap voltage	750 kV
Field at the cathode	19.47 MV/m
Q <sub>0</sub> (ideal copper)	30887
Shunt impedance	6.5 MΩ
RF Power @ Q <sub>0</sub>	87.5 kW
Stored energy	2.3 J
Peak surface field	24.1 MV/m
Peak wall power density	25.0 W/cm <sup>2</sup>
Accelerating gap	4 cm
Diameter/Length	69.4/35.0 cm
Operating pressure	$\sim 10^{-10}  10^{-9} \text{ Torr}$

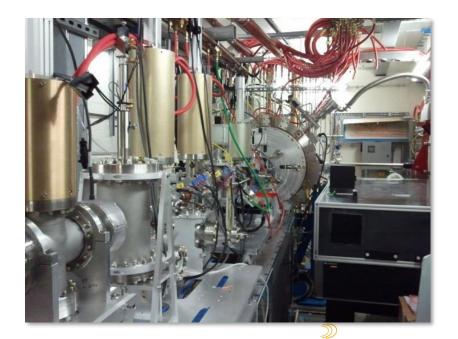
# **APEX Photoinjector**





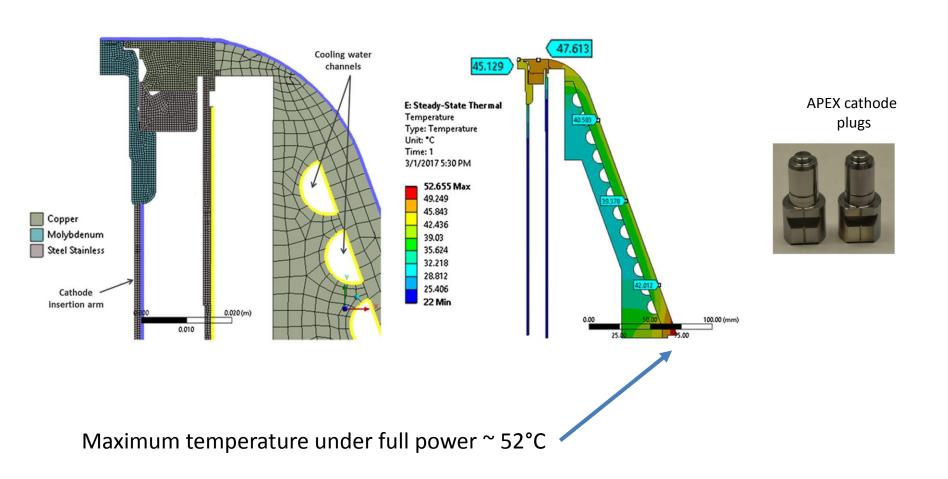




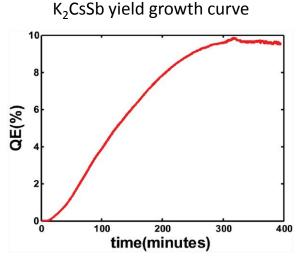


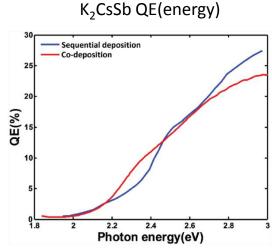
### **APEX Nosecone Heating**

F. Sannibale *et al.*, Advanced photoinjector experiment photogun commissioning results, Phys. Rev. ST Accel. Beams **15**, 103501 (2012).

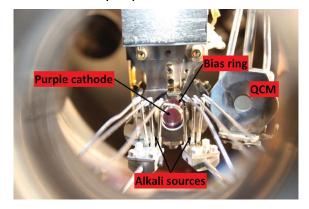


### **Ternary Co-evaporation of cathodes for APEX**





distinctive purple color cathodes



(a)

10

10

600

400

y in nm 200

0 0 200 x in nm

(b)

10

600

400

y in nm 200

0 0 200 x in nm

- Simultaneous deposition of Sb, K, Cs (90C)
  - 4 parameter initial search for correct conditions
- Very robust and repeatable method
- 7% QE is routinely achieved @ 532 nm

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#### Near atomically smooth alkali antimonide photocathode thin films

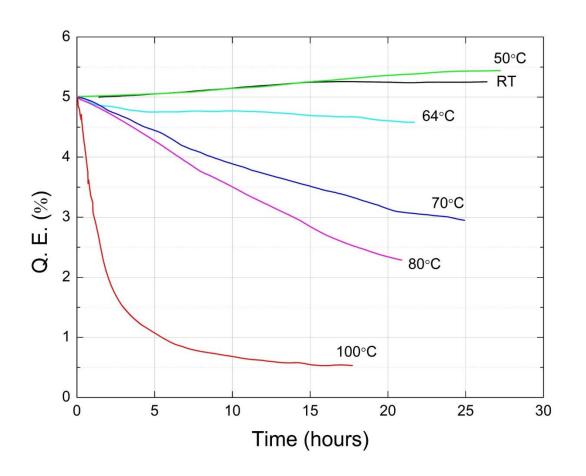
### Questions

- How is cathode lifetime affected by operating temperature
- What is the mechanism of thermal damage
- Can the QE be recovered in some way

### **Method**

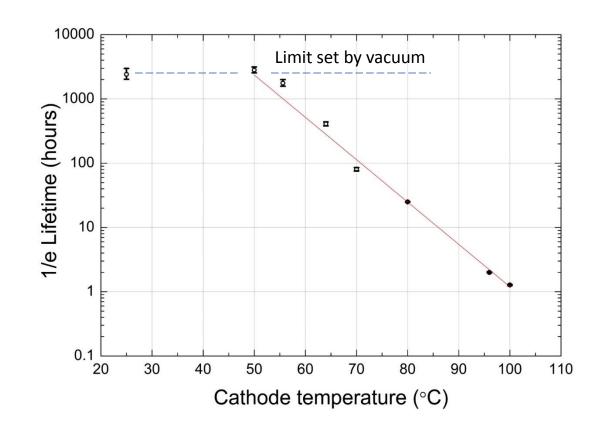
- Prepare many cathodes by co-deposition (K<sub>2</sub>CsSb, Cs<sub>3</sub>Sb)
  - measure QE (wavelength)
  - refine method to make cathodes as close to identical as possible
- Measure QE (time) at defined temperature
- Repeat for range of temperatures
  - 1 cathode for each temperature....a tedious measurement

# QE decay curves of K<sub>2</sub>CsSb at 532 nm

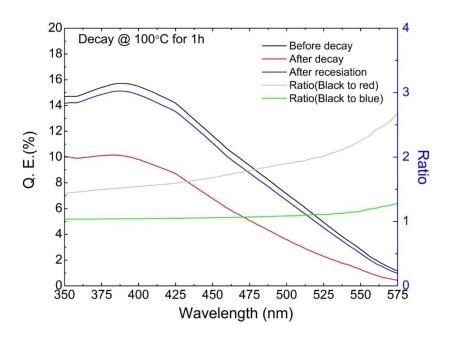


Initial QE in range 4.5 – 5.5% and normalized to 5%

# Lifetime of K<sub>2</sub>CsSb at 532 nm



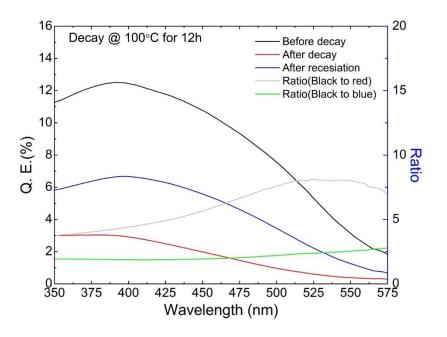
# K<sub>2</sub>CsSb: Full recovery of yield by re-cesiation: 100°C for 1 hr



#### 100°C for 1 hour

- Factor of 2.7 loss in QE @ 575 nm, 1.4 @ 350nm
- Re-cesiation recovers ~100% of QE

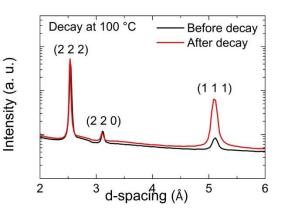
### K<sub>2</sub>CsSb: Partial recovery of yield by re-cesiation: 100°C for 12 hrs



#### 100°C for 12 hrs

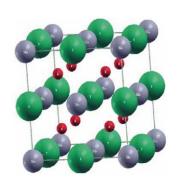
- Factor of 7 loss @ 575 nm, 3 @ 350 nm
- Re-cesiation recovers only a fraction of initial QE
  - 40% at 575 nm and 53% at 350 nm

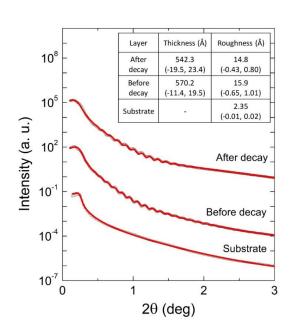
# K<sub>2</sub>CsSb: 100° C and 1.5 hrs induces structural changes



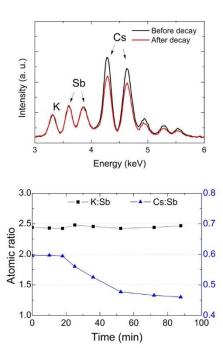


- (111) indicates strain or disorder
- Large (111) intensity after heating indicates disorder
- crystal symmetry remains the same after heating





- Thickness reduced by 5% after heating
- Out of plane roughness similar after heating



- x-ray induced x-ray fluorescence
  - Indicates loss of Cs
  - No loss of K or Sb

## **Summary: Thermal decomposition studies**

- Safe operating range with K<sub>2</sub>CsSb up to around 55°C
  - Slightly higher than APEX cathode when under full power
- Decomposition via loss of Cs, and partial recovery possible
- Cs<sub>3</sub>Sb much less stable, NaKSb much more stable

### **Workfunction Imaging using LEEM**

- S. Karkare\*, S. Emanian, G. Gevorkian\*, H. A. Padmore (ALS, LBNL: \* now ASU)
- A. Galdi (Cornell)
- A. Schmid (Molecular Foundry, LBNL)

- Emittance depend on physical and chemical roughness
  - Physical roughness UHV AFM
  - Chemical roughness KPFM, LEEM and PEEM

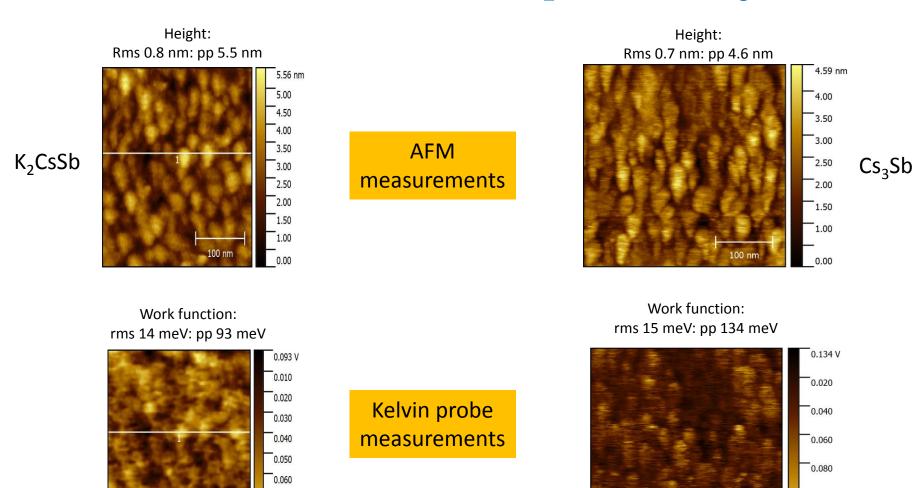








# Work function variation for K<sub>2</sub>CsSb and Cs<sub>3</sub>Sb



KPFM measurements difficult and somewhat unreliable

0.100

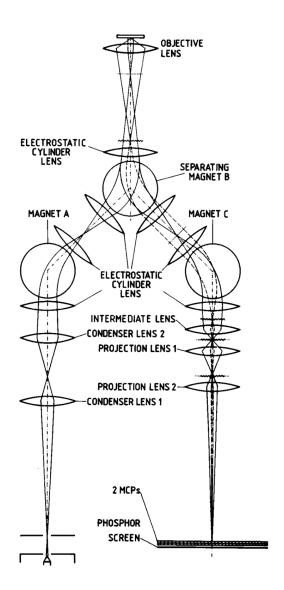
0.000

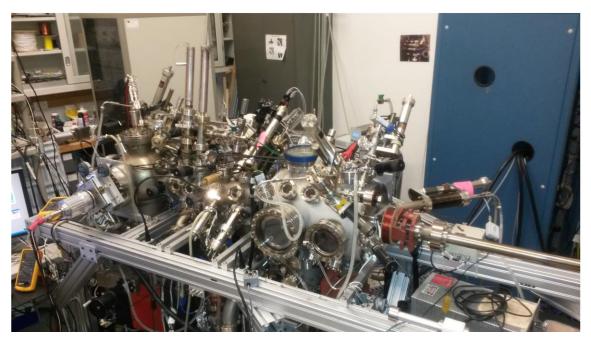
100 nm

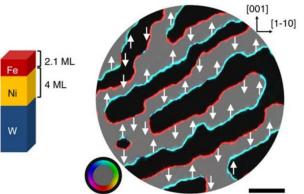
Use LEEM to measure work function

0.070

# **Spin Polarized Low Energy Electron Microscopy (SPLEEM)**







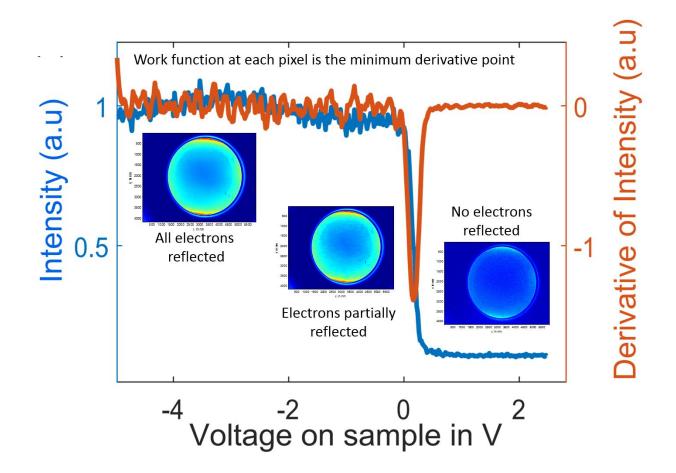
# Unlocking Bloch-type chirality in ultrathim magnets through uniaxial strain

Gong Chen ™, Alpha T. N'Diaye, Sang Pyo Kang, Hee Young Kwon, Changyeon Won, Yizheng Wu, Z. Q. Qiu & Andreas K. Schmid ™

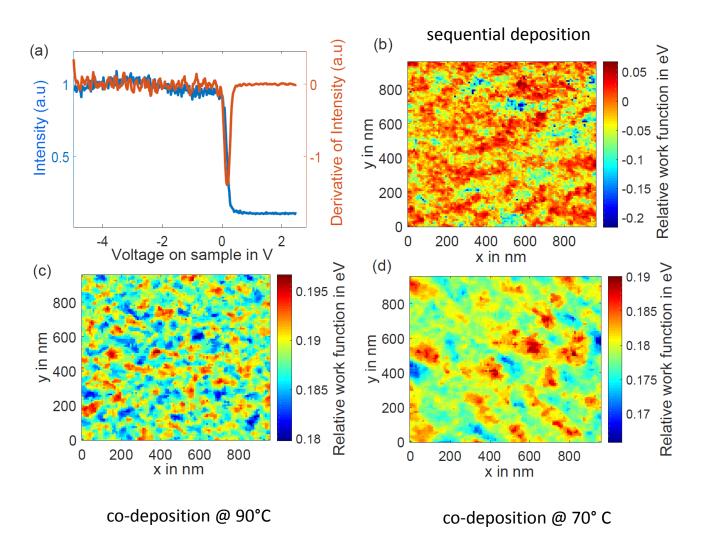
#### A flange-on type low energy electron microscope

K. Grzelakowski<sup>a)</sup> and E. Bauer Physikalisches Institut, Technische Universitaet Clausthal, D 38678 Clausthal-Zellerfeld, Germany

### (SP)LEEM measurements of work function



# LEEM measurement of work function of Cs<sub>3</sub>Sb

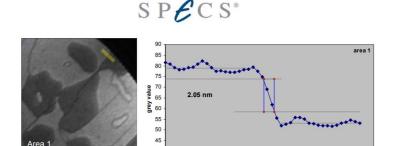


Same amplitude, much lower spatial frequencies at 70°C (lower transverse fields)

### **Summary: work function imaging using LEEM**

- 20 nm spatial resolution (2 nm)
- 5 meV work function 'noise'
- Chemical potential roughness causes strong lateral potential gradients that degrade emittance
- Strong dependence of gradients on deposition temperature
- More work to be done on Cs3Sb at different growth temperatures, rates, and other antimonides

Aberration corrected LEEM, 2 nm resolution



Ultramicroscopy

Volume 110, Issue 7, June 2010, Pages 852-861

A new aberration-corrected, energy-filtered LEEM/PEEM instrument. I. Principles and design

R.M. Tromp <sup>a</sup>  $\stackrel{\triangle}{\sim}$   $\stackrel{\boxtimes}{\sim}$  J.B. Hannon <sup>a</sup>, A.W. Ellis <sup>a</sup>, W. Wan <sup>b</sup>, A. Berghaus <sup>c</sup>, O. Schaff <sup>c</sup>

The best probe should be PEEM (photon energy).....1st attempt not successful due to low flux

New coherent supercontinuum source being tested.....a Fowler plot / pixel at few nm resolution!

# QUESTIONS